

<b>Notice of References Cited</b>	Application/Control No. 10/751,731	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Thomas D. Alunkal	Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,608,710	03-1997	Minemura et al.	369/47.51
*	C	US-6,529,467	03-2003	Miyamoto et al.	369/116
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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